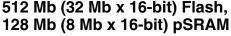
# **S71NS-R Memory Subsystem Solutions**

MirrorBit® 1.8 Volt-only Simultaneous Read/Write, **Burst Mode Multiplexed Flash Memory and Burst Mode pSRAM** 









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# **S71NS-R Memory Subsystem Solutions**

MirrorBit® 1.8 Volt-only Simultaneous Read/Write, Burst Mode Multiplexed Flash Memory and Burst Mode pSRAM

512 Mb (32 Mb x 16-bit) Flash, 128 Mb (8 Mb x 16-bit) pSRAM





### **Features**

- Power supply voltage of 1.7 V to 1.95 V
- Burst Speed (Flash and pSRAM): 104 MHz

- MCP BGA Package
  - 56 ball, 9.2 x 8.0 mm, 0.5 mm ball pitch
- Operating Temperature
  - Wireless. -25°C to +85°C

## **General Description**

The S71NS-R Series is a product line of stacked Multi-Chip Package (MCP) memory solutions and consists of the following items:

- One or more S29NS-R flash memory die
- One or more pSRAM

The products covered by this document are listed in the table below. For details about their specifications, please refer to their individual datasheet for further details.

Flash Density	pSRAM Density	Product	
512 Mb	128 Mb	S71NS512RD0	

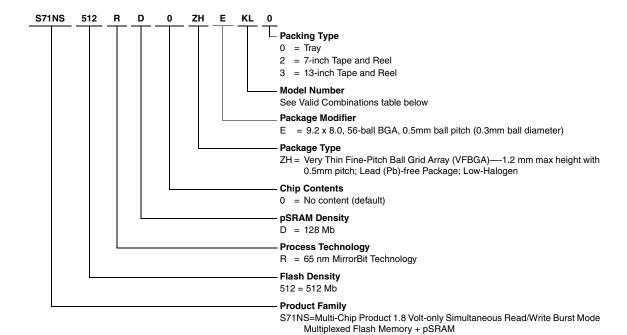
For detailed specifications, please refer to the individual data sheets:

Document	Publication Identification Number	
S29NS-R	S29NS-R_00	
128 Mb MUX pSRAM Type 5	psram_39	



## 1. Ordering Information

The order number is formed by a valid combinations of the following:



### 1.1 Valid Combinations

Valid Combinations list configurations planned to be supported in volume for this device. Consult your local sales office to confirm availability of specific valid combinations and to check on newly released combinations.

Base Ordering Part Number	Package	Model Number	Packing Type	pSRAM Type	MCP Speed	Boot
S71NS512RD0	ZHE	KL	0, 2, 3	Mux pSRAM Type 5	104 MHz	Uniform



# 2. Input/Output Descriptions

Table 2.1 identifies the input and output package connections provided on the device.

Table 2.1 Input/Output Descriptions

Symbol	Description	Flash	RAM
AMAX – A16	Address inputs	Х	Х
A/DQ15-A/DQ0	Multiplexed Address/Data	Х	Х
OE#	Output Enable input. Asynchronous relative to CLK for the Burst mode.	Х	Х
WE#	Write Enable input.	Х	Х
V <sub>SS</sub>	Ground	Х	Х
V <sub>SSQ</sub>	Input/Output Ground	Х	Х
NC	No Connect; not connected internally	Х	Х
F-RDY/R-WAIT	Ready output; indicates the status of the Burst read.   Flash Memory RDY (using default "Active HIGH" configuration) $V_{OL} = \text{data invalid}$ $V_{OH} = \text{data valid}$ Note: The default polarity for the pSRAM WAIT signal is opposite the default polarity of the Flash RDY signal.   pSRAM WAIT (using default "Active HIGH" configuration) $V_{OL} = \text{data valid}$ $V_{OH} = \text{data invalid}$ To match polarities, change bit 10 of the pSRAM Bus Configuration Register to 0 (Active LOW WAIT). Alternately, change bit 10 of the Flash Configuration Register to 0 (Active LOW RDN).	X	x
CLK	RDY)  Clock input. In burst mode, after the initial word is output, subsequent active edges of CLK increment the internal address counter. Should be at $V_{IL}$ or $V_{IH}$ while in asynchronous mode	Х	х
AVD#	Address Valid input. Indicates to device that the valid address is present on the address inputs.  Low = for asynchronous mode, indicates valid address; for burst mode, causes starting address to be latched.  High = device ignores address inputs	х	х
F-RST#	Hardware reset input. Low = device resets and returns to reading array data	X	
F-WP#	Hardware write protect input. At $V_{\rm IL}$ , disables program and erase functions in the four outermost sectors. Should be at $V_{\rm IH}$ for all other conditions.	Х	
F-V <sub>PP</sub>	Accelerated input. At $V_{HH}$ , accelerates programming; automatically places device in unlock bypass mode. At $V_{IL}$ , disables all program and erase functions. Should be at $V_{IH}$ for all other conditions.		
R-CE#	Chip-enable input for pSRAM.		Х
F-CE#	Chip-enable input for Flash. Asynchronous relative to CLK for Burst Mode.		
R-CRE	Control Register Enable (pSRAM).		Х
V <sub>CC</sub>	Flash and pSRAM 1.8 Volt-only single power supply.	Х	Х
V <sub>CCQ</sub>	Flash and pSRAM Input/Output Power Supply	Х	Х
R-UB#	Upper Byte Control (pSRAM).		Х
R-LB#	Lower Byte Control (pSRAM)		Х
RFU	Reserved For Future Use		



## **MCP Block Diagram**

Figure 3.1 MCP Block Diagram F-RST#-RST# ADQ15-ADQ0 ADQ15-ADQ0 VPP F-VPP CLK F-RDY / R-WAIT RDY F-CE# CE# NS-R OE# OE# WE# □ A22-A16 A22-A16 WE#-AVD#-AVD# VCC VCC VSS VSS VCCQ VCCQ VSSQ VSSQ R-UB# UB# ADQ15-ADQ0 CLK R-LB# LB# R-CE# CE# WAIT pSRAM OE# WE# A22-A16 ADV# R-CRE CRE VCC VSS VCCQ VSSQ



## 4. Connection Diagrams/Physical Dimensions

This section contains the I/O designations and package specifications for the S71NS-R.

## 4.1 Special Handling Instructions for FBGA Packages

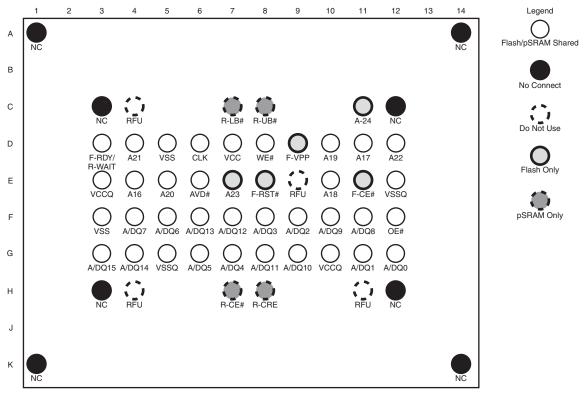
Special handling is required for Flash Memory products in FBGA packages.

Flash memory devices in FBGA packages may be damaged if exposed to ultrasonic cleaning methods. The package and/or data integrity may be compromised if the package body is exposed to temperatures above 150°C for prolonged periods of time.

## 4.2 Connection Diagrams

Figure 4.1 56-ball Fine-Pitch Ball Grid Array

(Top View, Balls Facing Down)



#### Note:

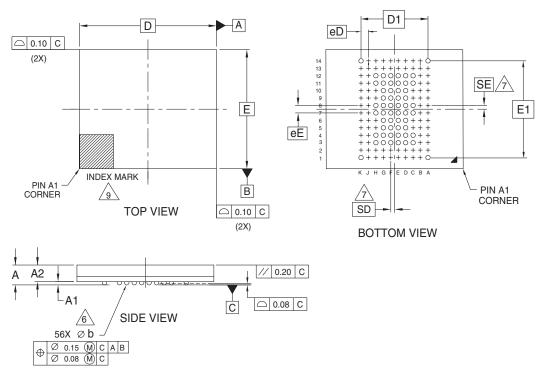
Addresses are shared between Flash and RAM depending on the density of the pSRAM.

MCP	Flash-Only Addresses	Shared Addresses	Shared ADQ Pins
S71NS512RD0	A24-A23	A22-A16	A/DQ15-A/DQ0



## 4.3 Physical Dimensions

Figure 4.2 NLB056—56-ball VFBGA 8.0 x 9.2 mm



PACKAGE	NLB 056			
JEDEC	N/A			
DxE	9.20 mm x 8.00 mm PACKAGE		mm	
SYMBOL	MIN	NOM	MAX	NOTE
Α			1.20	PROFILE
A1	0.20			BALL HEIGHT
A2	0.85		0.97	BODY THICKNESS
D		9.20 BSC.		BODY SIZE
E		8.00 BSC.		BODY SIZE
D1		4.50 BSC.		MATRIX FOOTPRINT
E1	6.50 BSC.			MATRIX FOOTPRINT
MD	10			MATRIX SIZE D DIRECTION
ME	14			MATRIX SIZE E DIRECTION
n	56			BALL COUNT
Øb	0.25	0.30	0.35	BALL DIAMETER
eЕ	0:50 BSC.			BALL PITCH
eD	0.50 BSC			BALL PITCH
SD / SE	0.25 BSC.			SOLDER BALL PLACEMENT
	A2 - A13,B1 - B14 C1,C2,C5,C6,C9,C10,C13,C14 D1,D2,D13,D14,E1,E2,E13,E14,F1,F2,F13,F14 G1,G2,G13,G14,H1,H2,H5,H6,H9,H10,H13,H14 J1 - J14, K2 - K13		13,C14 F1,F2,F13,F14 9,H10,H13,H14	DEPOPULATED SOLDER BALLS

### NOTES:

- DIMENSIONING AND TOLERANCING METHODS PER ASME Y14.5M-1994.
- 2. ALL DIMENSIONS ARE IN MILLIMETERS.
- 3. BALL POSITION DESIGNATION PER JEP95, SECTION 4.3, SPP-010.
- 4. e REPRESENTS THE SOLDER BALL GRID PITCH.
- 5. SYMBOL "MD" IS THE BALL MATRIX SIZE IN THE "D" DIRECTION.

SYMBOL "ME" IS THE BALL MATRIX SIZE IN THE "E" DIRECTION.

 $\ensuremath{\mathsf{n}}$  IS THE NUMBER OF POPULTED SOLDER BALL POSITIONS FOR MATRIX SIZE MD X ME.

DIMENSION "b" IS MEASURED AT THE MAXIMUM BALL DIAMETER IN A PLANE PARALLEL TO DATUM C.

SD AND SE ARE MEASURED WITH RESPECT TO DATUMS A AND B AND DEFINE THE POSITION OF THE CENTER SOLDER BALL IN THE OUTER ROW.

WHEN THERE IS AN ODD NUMBER OF SOLDER BALLS IN THE OUTER ROW SD OR SE = 0.000.

WHEN THERE IS AN EVEN NUMBER OF SOLDER BALLS IN THE OUTER ROW, SD OR SE =  $\boxed{0/2}$ 

8. "+" INDICATES THE THEORETICAL CENTER OF DEPOPULATED BALLS.

A1 CORNER TO BE IDENTIFIED BY CHAMFER, LASER OR INK MARK, METALLIZED MARK INDENTATION OR OTHER MEANS.

10. OUTLINE AND DIMENSIONS PER CUSTOMER REQUIREMENT.

3507\ 16-038.22 \ 7.14.5



# 5. Revision History

Section	Description		
Revision 01 (January 14, 2008)			
	Initial release		
Revision 02 (February 11, 2008)			
Global	Added OPN S71NS256RC0ZHKJL		
Revision 03 (September 10, 2008)			
Global	Added OPN S71NS512RD0ZHEKL		
Revision 04 (October 6, 2008)			
Global	Removed OPNs S71NS256RC0ZHKJL, S71NS256RD0ZHEJL, and S71NS512RD0ZHEJL		
Physical Dimensions	Removed packages NLD056 and NSB056		
Revision 05 (April 9, 2009)			
Physical Dimensions	Updated package drawing for NLB056		



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